

**INFORMATION DISCLOSURE  
STATEMENT BY  
APPLICANTS  
PTO FORM 1449**

Atty. Docket No.  
10191/1924

Serial No.  
To Be Assigned

Applicant(s)  
BENZEL et al.

Filing Date  
Herewith

Group  
To Be Assigned

U.S. PTO  
10/17/72  
10/29/01

**U. S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>H</i>	5,714,791*	Feb. 3, 1998	CHI et al.			

\* Described in the Specification.

**FOREIGN PATENT DOCUMENTS**

EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO
<i>H</i>	WO 96 05506*	Feb. 22, 1996	PCT				

\* Described in the Specification.

**OTHER DOCUMENTS**

EXAMINER'S INITIALS	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
<i>H</i>	D. Heinze, <i>Semiconductor Technologies for Manufacturing Modern Moisture Sensors</i> , Sensor 91, Nuremberg 1991, Kongreßband (Convention Volume) IV, 112-121).*
<i>H</i>	Lammel et al., <i>Free-standing Mobile 3D Microstructures of Porous Silicon</i> , Proceedings of the 13th European Conference on Solid-State Transducers, Eurosensors XIII, The Hague, 1999, 535-536.*

\* Described in the Specification.

EXAMINER <i>AD</i> <i>AD</i>	DATE CONSIDERED <i>11-7-02</i>
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	